

C2012X8R1E105M125AC

TDK Item Description : C2012X8R1E105MT****



Application & Main Feature

Commercial Grade (High Temperature Application)

Series

C2012 [EIA 0805]



Dimensions

L	2.00mm +/-0.2mm
W	1.25mm +/-0.2mm
T	1.25mm +/-0.2mm
B	0.20mm Min.
G	0.50mm Min.

Temperature Characteristic

X8R (-55 to 150 deg +/-15%)

Rated Voltage

1E (25Vdc)

Capacitance

1uF

Capacitance Tolerance

M (+/-20%)

Dissipation Factor

5% Max.

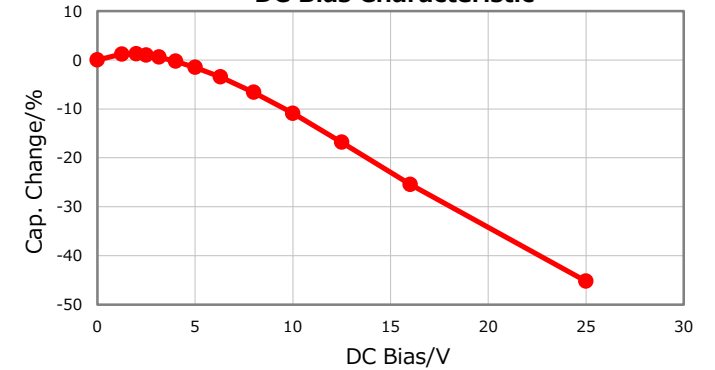
Insulation Resistance

500Mohm Min.

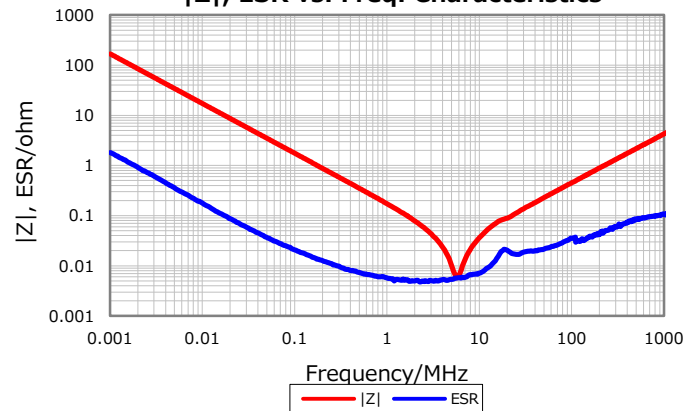
AEC-Q200

Not Applicable

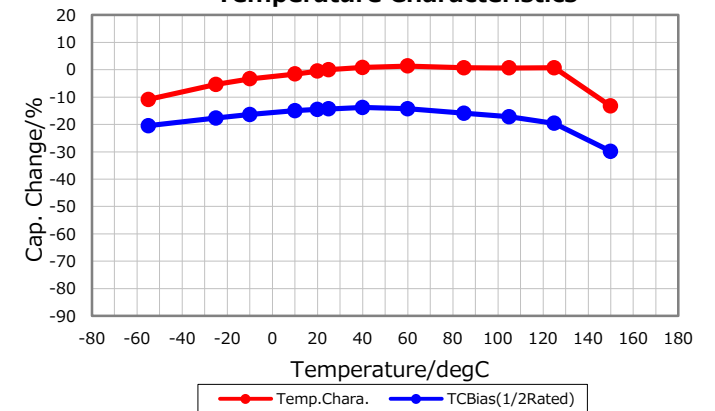
DC Bias Characteristic



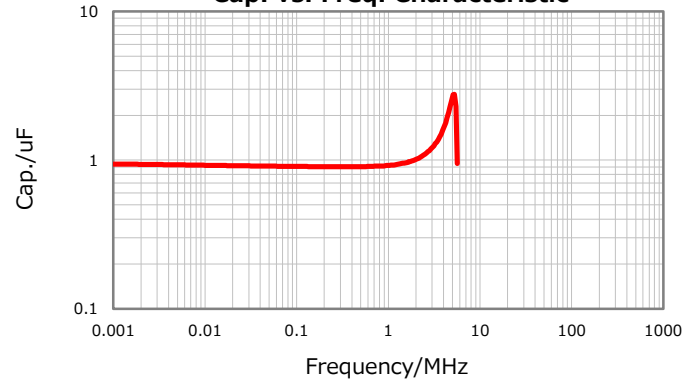
|Z|, ESR vs. Freq. Characteristics



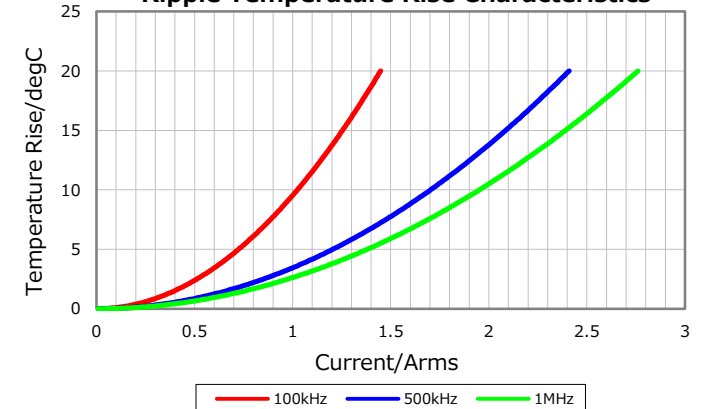
Temperature Characteristics



Cap. vs. Freq. Characteristic



Ripple Temperature Rise Characteristics



Characterization Sheet (Multilayer Ceramic Chip Capacitors)



All specifications are subject to change without notice.

June 5, 2018